Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/007,465	ECKEL ET AL.	
Examiner	Art Unit	
David Buttner	1712	

	SEAR	CHED	
Class	Subclass	Date	Examiner
525	67	4/13/2005	DB
524	127	4/13/2005	DB
524	141	4/13/2005	DB
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INT	INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner	
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SEARCH (INCLUDING SEAI	SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR		
east	4/13/2005	DB		